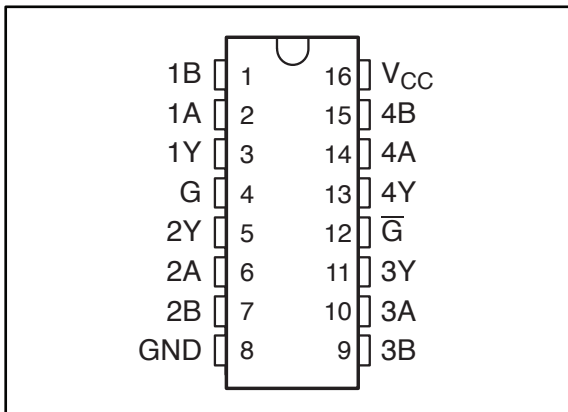


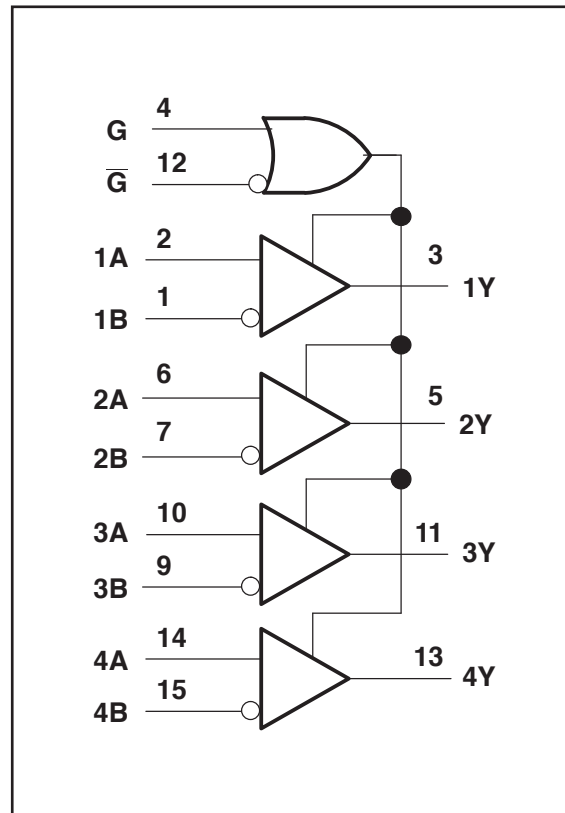
Quad Differential LVDS/LVPECL/HSTL to LVTTTL Translator

FEATURES:	DESCRIPTION:
<ul style="list-style-type: none"> • Patented Technology • Differential LVDS/LVPECL/HSTL to LVTTTL Translator • Operating frequency up to 1GHz with 2pf load • Operating frequency up to 800MHz with 5pf load • Operating frequency up to 450MHz with 15pf load • Very low output pin to pin skew < 150ps • Propagation delay < 1.8ns max with 15pf load • 2.4V to 3.6V power supply • Industrial temperature range: -40°C to 85°C • Available in 16-pin SOIC 150ml package 	<p>Potato Semiconductor's PO100HSTL32A is designed for world top performance using submicron CMOS technology to achieve 1GHz LVTTTL output frequency with less than 1.8ns propagation delay.</p> <p>The PO100HSTL32A is a low-skew, The small outline 16 pin package and the low skew design to make it ideal for applications which require the translation of a clock or a data signal.</p>

Pin Configuration



Logic Block Diagram



Pin Description

DIFFERENTIAL INPUT A, B	ENABLES		OUTPUT Y
	G	\bar{G}	
$V_{ID} \geq 10 \text{ mV}$	H	X	H
$-10 \text{ mV} < V_{ID} < 10 \text{ mV}$	H	X	?
$V_{ID} \leq -10 \text{ mV}$	X	L	?
$V_{ID} \leq -10 \text{ mV}$	H	X	L
X	X	L	L
X	L	H	Z
Open	H	X	H
Open	X	L	H

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Maximum Ratings

Description	Max	Unit
Storage Temperature	-65 to 150	°C
Operation Temperature	-40 to 85	°C
Operation Voltage	-0.5 to +4.6	V
Input Voltage	-0.5 to Vcc	V
Output Voltage	-0.5 to Vcc+0.5	V

Note:

stresses greater than listed under Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability specification is not implied.

Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input B Pullup Resistor			88		KΩ
R _{PULLDOWN}	Input A Pulldown Resistor			88		KΩ

DC Electrical Characteristics

Symbol	Description	Test Conditions	Min	Typ	Max	Unit
V _{OH}	Output High voltage	Vcc=3V Vin=VIH or VIL, IOH= -12mA	2.4	3	-	V
V _{OL}	Output Low voltage	Vcc=3V Vin=VIH or VIL, IOH=12mA	-	0.3	0.5	V
V _{IH}	Input High voltage	Guaranteed Logic HIGH Level (Input Pin)	2	-	Vcc	V
V _{IL}	Input Low voltage	Guaranteed Logic LOW Level (Input Pin)	-0.5	-	0.8	V
I _{IH}	Input High current	Vcc = 3.6V and Vin = Vcc	-	-	1	uA
I _{IL}	Input Low current	Vcc = 3.6V and Vin = 0V	-	-	-1	uA
V _{IK}	Clamp diode voltage	Vcc = Min. And IIN = -18mA	-	-0.7	-1.2	V

Notes:

1. For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
2. Typical values are at Vcc = 3.3V, 25 °C ambient.
3. This parameter is guaranteed but not tested.
4. Not more than one output should be shorted at one time. Duration of the test should not exceed one second.
5. VoH = Vcc - 0.6V at rated current

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Power Supply Characteristics

Symbol	Description	Test Conditions (1)	Min	Typ	Max	Unit
IccQ	Quiescent Power Supply Current	Vcc=Max, Vin=Vcc or GND	-	0.1	30	uA

Notes:

1. For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
2. Typical values are at Vcc = 3.3V, 25°C ambient.
3. This parameter is guaranteed but not tested.
4. Not more than one output should be shorted at one time. Duration of the test should not exceed one second.

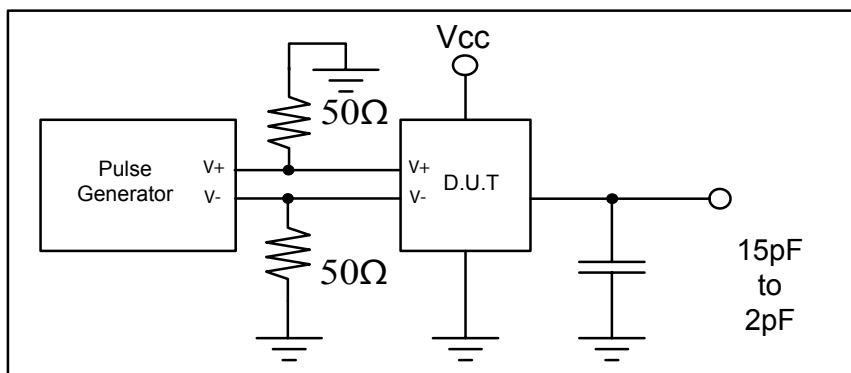
Switching Characteristics

Symbol	Description	Test Conditions (1)	Max	Unit
t_{PD}	Propagation Delay D to Output pair	CL = 15pF	1.8	ns
t_{PZH} or t_{PZL}	Output Enable Time	CL = 15pF	2.5	ns
t_{PHZ} or t_{PLZ}	Output Disable Time	CL = 15pF	2.5	ns
t_r/t_f	Rise/Fall Time	0.8V – 2.0V	0.8	ns
tsk(o)	Output Pin to Pin Skew (Same Package)	CL = 15pF, 125MHz	150	ps
tsk(pp)	Output Skew (Different Package)	CL = 15pF, 125MHz	300	ps
f_{max}	Input Frequency	CL = 15pF	450	MHz
f_{max}	Input Frequency	CL = 5pF	800	MHz
f_{max}	Input Frequency	CL = 2pF	1000	MHz

Notes:

1. See test circuits and waveforms.
2. t_{pLH}, t_{pHL}, tsk(p), and tsk(o) are production tested. All other parameters guaranteed but not production tested.
3. Airflow of 1m/s is recommended for frequencies above 133MHz

Test Circuit



Quad Differential LVDS/LVPECL/HSTL to LVTTTL Translator

Test Waveforms

FIGURE 1. LVDS/ PECL/ ECL/ HSTL /DIFFERENTIAL INPUT WAVEFORM DEFINITIONS

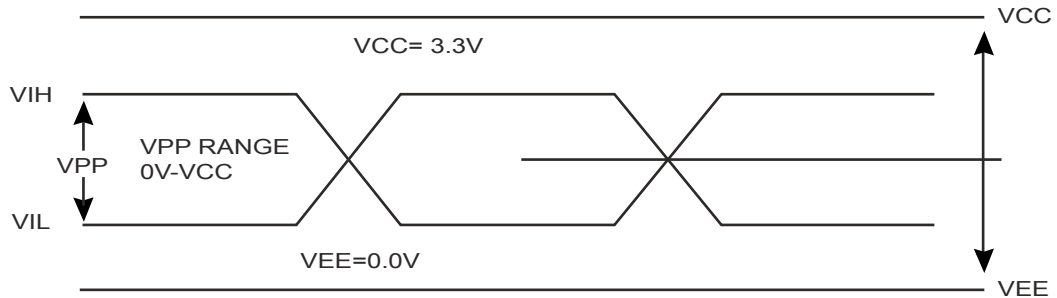


FIGURE 2. LVTTTL OUTPUT

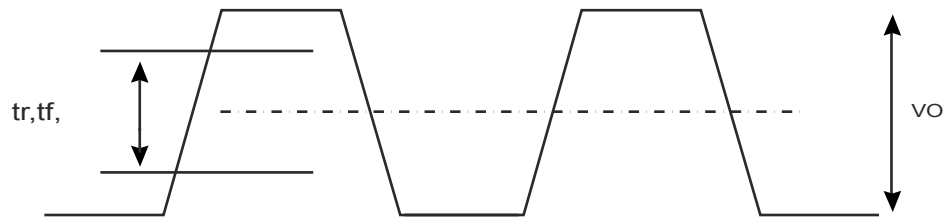
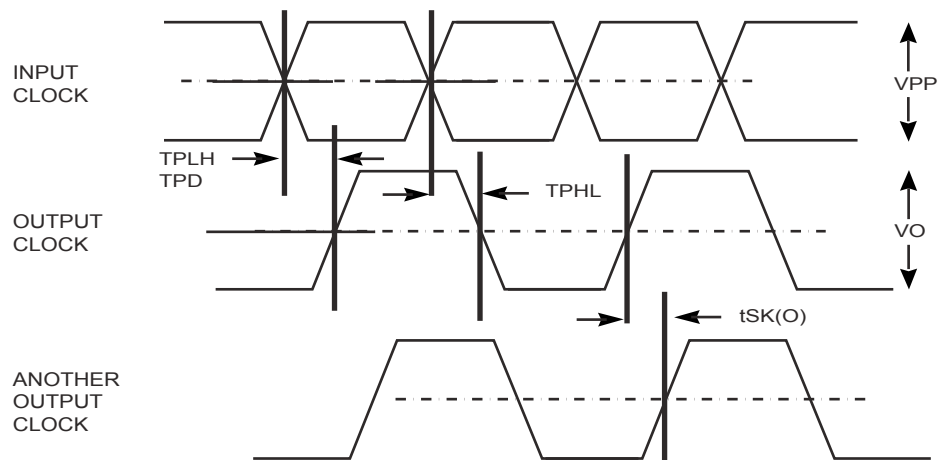
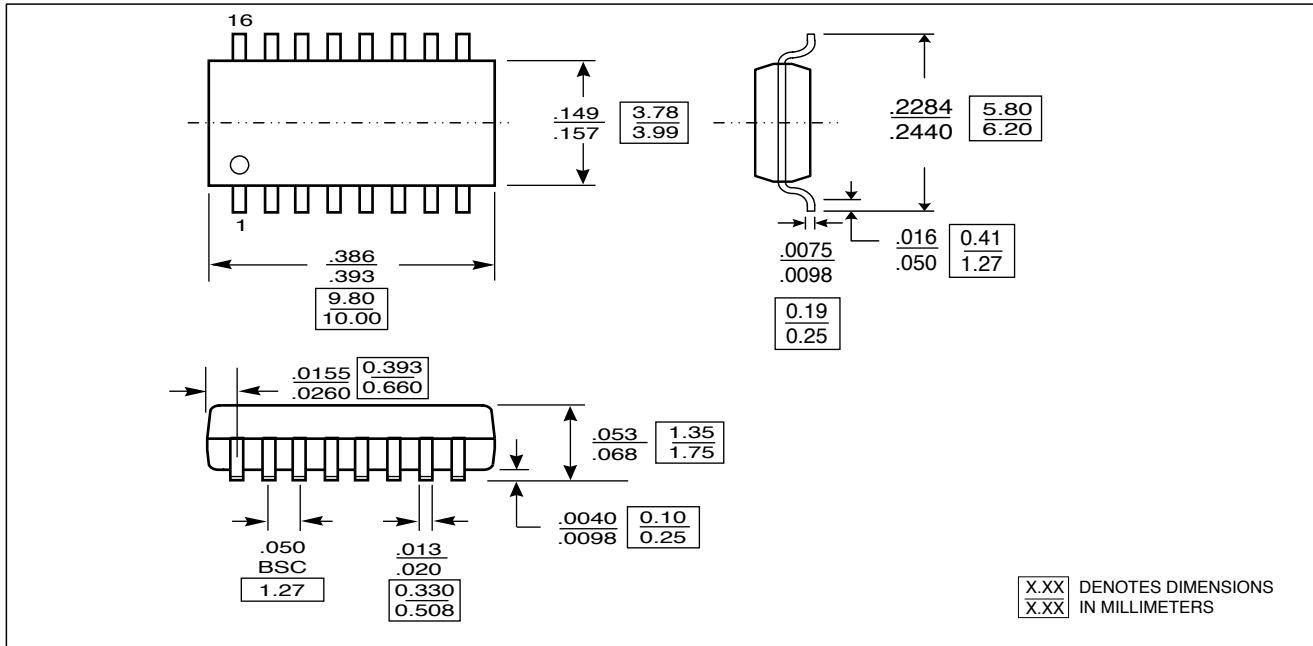


FIGURE 3. Propagation Delay, Output pulse skew, and output-to-output skew for D to output



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Packaging Mechanical Drawing: 16 pin SOIC



Ordering Information

Ordering Code	Package			Top-Marking	T _A
PO100HSTL32ASU	16-pin SOIC	Tube	Pb-free & Green	PO100HSTL32AS	-40°C to 85°C
PO100HSTL32ASR	16-pin SOIC	Tape and reel	Pb-free & Green	PO100HSTL32AS	-40°C to 85°C

IC Package Information

PACKAGE CODE	PACKAGE TYPE	TAPE WIDTH (mm)	TAPE PITCH (mm)	PIN 1 LOCATION	TAPE TRAILER LENGTH	QTY PER REEL	TAPE LEADER LENGTH	QTY PER TUBE
S	SOIC 16	16	8	Top Left Corner	39 (12")	3000	64 (20")	48